

<b>Notice of References Cited</b>	Application/Control No. 10/810,469	Applicant(s)/Patent Under Reexamination BONALLE ET AL.	
	Examiner William L. Bangachon	Art Unit 2612	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,747,546	06-2004	Hikita et al.	340/10.31
*	B	US-4,868,849	09-1989	Tamaoki, Ryokichi	379/357.01
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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